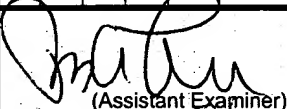
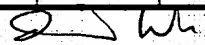



### Issue Classification

<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
09/530,803	CROZIER, HERVE	
<b>Examiner</b>	<b>Art Unit</b>	
Rip A. Lee	1713	

ISSUE CLASSIFICATION													
ORIGINAL					CROSS REFERENCE(S)								
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							
524		583			524	477	490						
INTERNATIONAL CLASSIFICATION					525	240	216	241					
C	0	8	L	23/12									
C	0	8	L	5/01									
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 (Assistant Examiner)		JAN 18 2006 (Date)	 DAVID W. WU SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700 (Primary Examiner)		1/19/06 (Date)	Total Claims Allowed: 14	
 (Legal Instruments Examiner)		1-19-06 (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. ---

[illegible]